


<b>Search Notes</b>  	<b>Application/Control No.</b>  10506799	<b>Applicant(s)/Patent Under Reexamination</b>  LOPEZ BOSIO ET AL.
	<b>Examiner</b>  HUYEN D LE	<b>Art Unit</b>  2614

SEARCHED			
Class	Subclass	Date	Examiner
381	111, 152, 337, 338, 353, 354, 396, 403, 404, 426, 431, 433	12/04/08	HL

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/HUYEN D LE/ Primary Examiner.Art Unit 2614
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